

International Rectifier

Applications

- Isolation Switch for Input Power or Battery Application
- High Side Switch for Inverter Applications

Features and Benefits

- Environmentally Friendly Product
- RoHS Compliant Containing no Lead, no Bromide and no Halogen
- Common-Drain P-Channel MOSFETs Provides High Level of Integration and Very Low RDS(on)

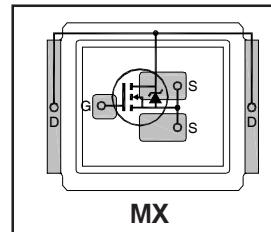
IRF9383MPbF

IRF9383MTRPbF

DirectFET® P-Channel Power MOSFET ②

Typical values (unless otherwise specified)

V_{DSS}	V_{GS}	$R_{DS(on)}$	$R_{DS(on)}$
-30V max	$\pm 20V$ max	2.3mΩ @ -10V	3.8mΩ @ -4.5V
$Q_{g\text{ tot}}$	Q_{gd}	Q_{gs2}	Q_{rr}
67nC	29nC	9.4nC	315nC
$V_{gs(\text{th})}$			
			-1.8V



Applicable DirectFET Outline and Substrate Outline (see p.7,8 for details) ①

SQ	SX	ST		MQ	MX	MT	MP	MC		
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Description

The IRF9383MTRPbF combines the latest HEXFET® P-Channel Power MOSFET Silicon technology with the advanced DirectFET® packaging to achieve the lowest on-state resistance in a package that has the footprint of a SO-8 and only 0.6 mm profile. The DirectFET® package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET package allows dual sided cooling to maximize thermal transfer in power systems, improving previous best thermal resistance by 80%.

Orderable part number	Package Type	Standard Pack		Note
		Form	Quantity	
IRF9383MTRPbF	DirectFET Medium Can	Tape and Reel	4800	
IRF9383MTR1PbF	DirectFET Medium Can	Tape and Reel	1000	

Absolute Maximum Ratings

	Parameter	Max.	Units
V_{DS}	Drain-to-Source Voltage	-30	
V_{GS}	Gate-to-Source Voltage	± 20	V
$I_D @ T_A = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$ ③	-22	
$I_D @ T_A = 70^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$ ③	-17	
$I_D @ T_C = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$ ④	-160	A
I_{DM}	Pulsed Drain Current ⑤	-180	

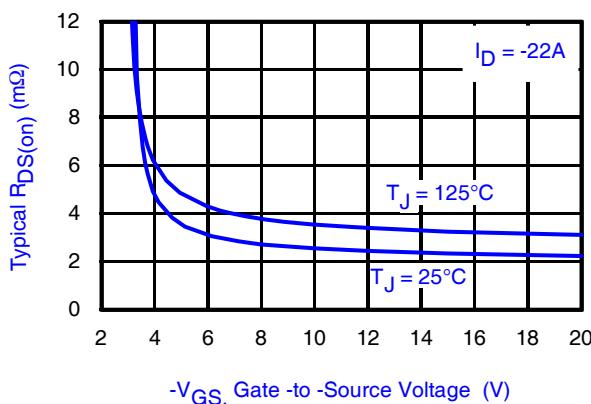


Fig 1. Typical On-Resistance vs. Gate Voltage

Notes:

- ① Click on this section to link to the appropriate technical paper.
- ② Click on this section to link to the DirectFET Website.
- ③ Surface mounted on 1 in. square Cu board, steady state.

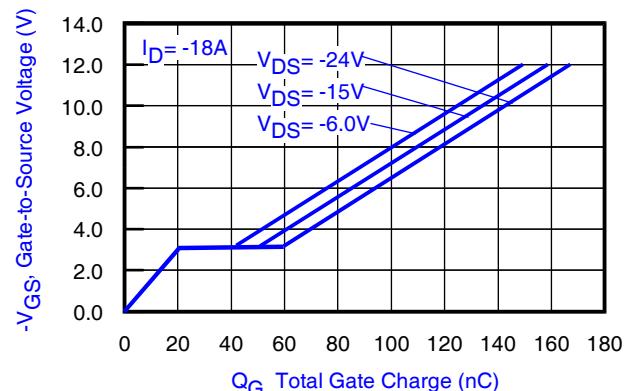


Fig 2. Typical Total Gate Charge vs Gate-to-Source Voltage

④ T_C measured with thermocouple mounted to top (Drain) of part.

⑤ Repetitive rating; pulse width limited by max. junction temperature.

Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	-30	—	—	V	$V_{\text{GS}} = 0\text{V}$, $I_D = -250\mu\text{A}$
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.0159	—	V/ $^\circ\text{C}$	Reference to 25°C , $I_D = -1.0\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	2.3	2.9	$\text{m}\Omega$	$V_{\text{GS}} = -10\text{V}$, $I_D = -22\text{A}$ ⑥
		—	3.8	4.8		$V_{\text{GS}} = -4.5\text{V}$, $I_D = -18\text{A}$ ⑥
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	-1.3	-1.8	-2.4	V	$V_{\text{DS}} = V_{\text{GS}}$, $I_D = -150\mu\text{A}$
$\Delta V_{\text{GS}(\text{th})}/\Delta T_J$	Gate Threshold Voltage Coefficient	—	-5.9	—	mV/ $^\circ\text{C}$	
I_{DSS}	Drain-to-Source Leakage Current	—	—	-1.0	μA	$V_{\text{DS}} = -24\text{V}$, $V_{\text{GS}} = 0\text{V}$
		—	—	-150		$V_{\text{DS}} = -24\text{V}$, $V_{\text{GS}} = 0\text{V}$, $T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	-100	nA	$V_{\text{GS}} = -20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	100		$V_{\text{GS}} = 20\text{V}$
g_{fs}	Forward Transconductance	56	—	—	S	$V_{\text{DS}} = -10\text{V}$, $I_D = -18\text{A}$
Q_g	Total Gate Charge	—	130	—	nC	$V_{\text{DS}} = -15\text{V}$, $V_{\text{GS}} = -10\text{V}$, $I_D = -18\text{A}$
Q_g	Total Gate Charge	—	67	—		$V_{\text{DS}} = -15\text{V}$
$Q_{\text{gs}1}$	Pre- V_{th} Gate-to-Source Charge	—	12	—		$V_{\text{GS}} = -4.5\text{V}$
$Q_{\text{gs}2}$	Post - V_{th} Gate-to-Source Charge	—	9.4	—		$I_D = -18\text{A}$
Q_{gd}	Gate-to-Drain Charge	—	29	—		See Fig.15
Q_{godr}	Gate Charge Overdrive	—	16.6	—		
Q_{sw}	Switch charge ($Q_{\text{gs}2} + Q_{\text{gd}}$)	—	38.4	—	nC	$V_{\text{DS}} = -24\text{V}$, $V_{\text{GS}} = 0\text{V}$
Q_{oss}	Output Charge	—	59	—		$V_{\text{DS}} = -24\text{V}$, $V_{\text{GS}} = 0\text{V}$
R_G	Gate Resistance	—	6.5	—	Ω	$V_{\text{DD}} = -15\text{V}$, $V_{\text{GS}} = -4.5\text{V}$ ⑥
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	29	—	ns	$I_D = -18\text{A}$
t_r	Rise Time	—	160	—		$R_G = 1.8\Omega$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	115	—		See Fig.17
t_f	Fall Time	—	110	—	pF	$V_{\text{GS}} = 0\text{V}$ $V_{\text{DS}} = -15\text{V}$ $f = 1.0\text{KHz}$
C_{iss}	Input Capacitance	—	7305	—		
C_{oss}	Output Capacitance	—	1780	—		
C_{rss}	Reverse Transfer Capacitance	—	1030	—		

Diode Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	-114	A	MOSFET symbol showing the integral reverse p-n junction diode.
	Pulsed Source Current (Body Diode) ⑤	—	—	-180		
V_{SD}	Diode Forward Voltage	—	—	-1.2	V	$T_J = 25^\circ\text{C}$, $I_S = -18\text{A}$, $V_{\text{GS}} = 0\text{V}$ ⑥
t_{rr}	Reverse Recovery Time	—	52	78	ns	$T_J = 25^\circ\text{C}$, $I_F = -18\text{A}$, $V_{\text{DD}} = -15\text{V}$
Q_{rr}	Reverse Recovery Charge	—	315	470	nC	$dI/dt = 500\text{A}/\mu\text{s}$ ⑥

Notes:⑥ Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.

Absolute Maximum Ratings

	Parameter	Max.	Units
P _D @ T _A = 25°C	Power Dissipation ③	2.1	W
P _D @ T _A = 70°C	Power Dissipation ③	1.3	
P _D @ T _C = 25°C	Power Dissipation ④	113	
T _P	Peak Soldering Temperature	270	°C
T _J T _{STG}	Operating Junction and Storage Temperature Range	-40 to + 150	

Thermal Resistance

	Parameter	Typ.	Max.	Units
R _{0JA}	Junction-to-Ambient ③	—	60	°C/W
R _{0JA}	Junction-to-Ambient ⑦	12.5	—	
R _{0JA}	Junction-to-Ambient ⑧	20	—	
R _{0JC}	Junction-to-Case ④,⑨	—	1.1	
R _{0J-PCB}	Junction-to-PCB Mounted	1.0	—	
	Linear Derating Factor ③	0.02		W/°C

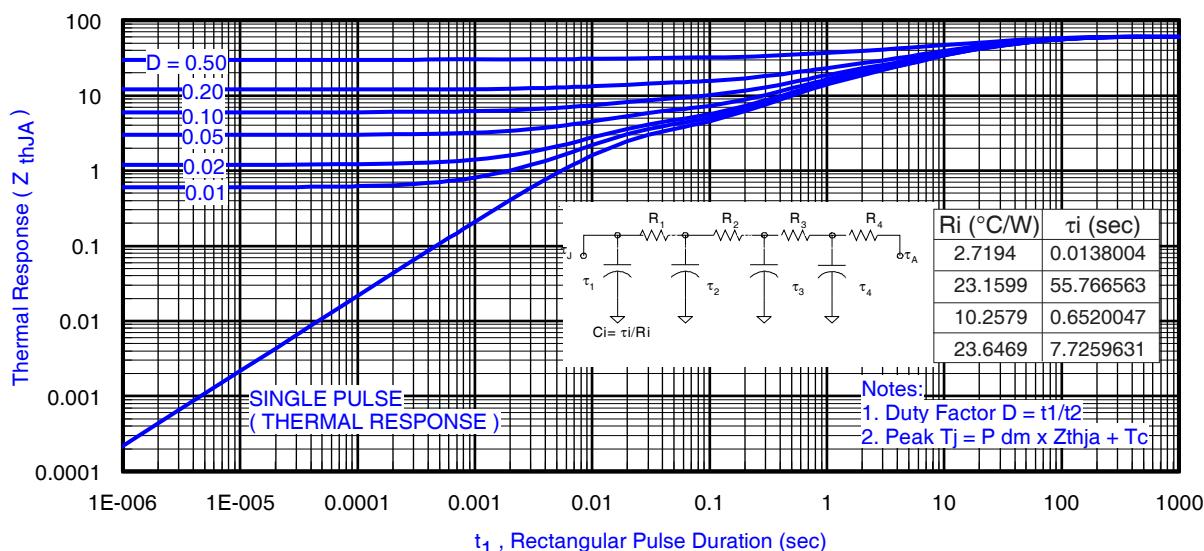
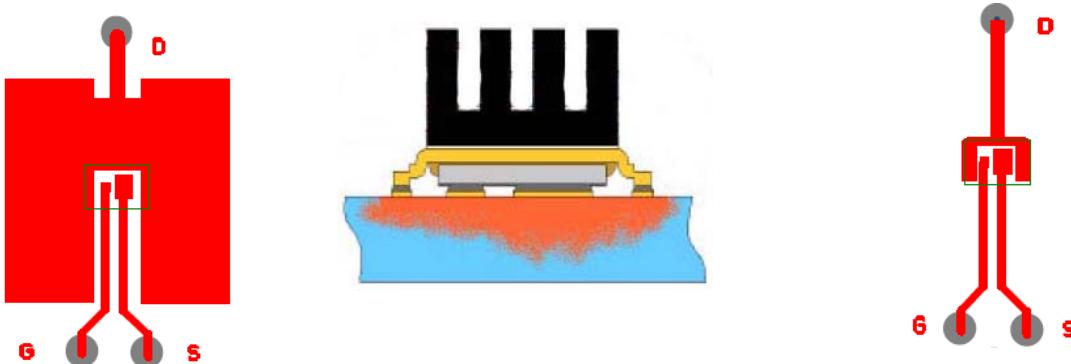


Fig 3. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient ①

Notes:

- ⑦ Used double sided cooling, mounting pad with large heatsink.
- ⑧ Mounted on minimum footprint full size board with metalized back and with small clip heatsink.

⑨ R₀ is measured at T_j of approximately 90°C.



③ Surface mounted on 1 in. square Cu board (still air).

⑨ Mounted to a PCB with small clip heatsink (still air)

⑨ Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air)

IRF9383MTRPbF

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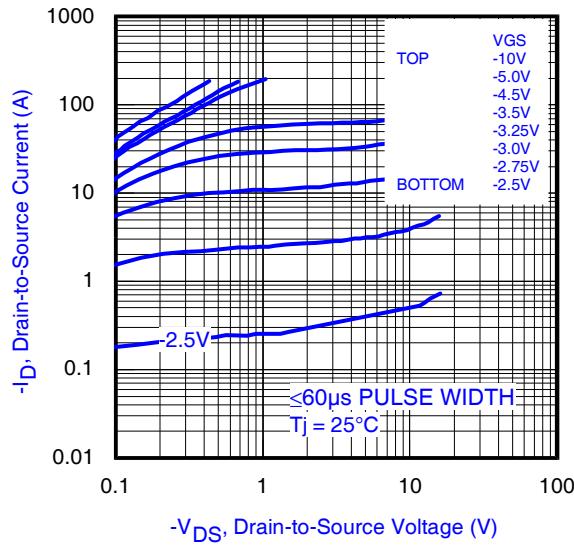


Fig 4. Typical Output Characteristics

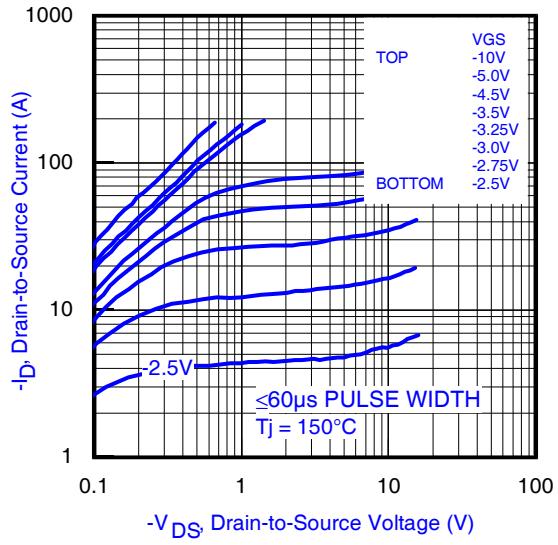


Fig 5. Typical Output Characteristics

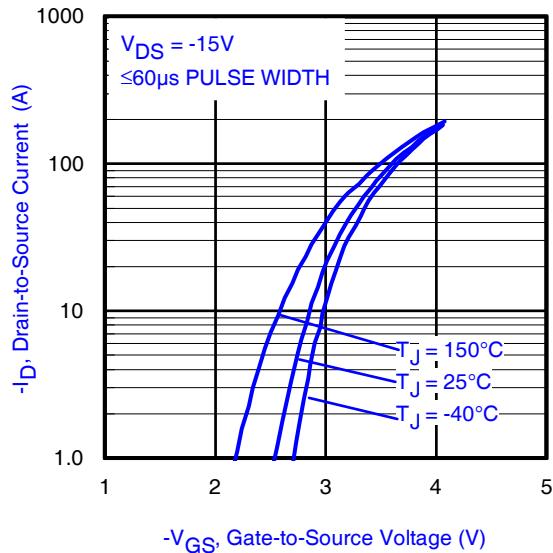


Fig 6. Typical Transfer Characteristics

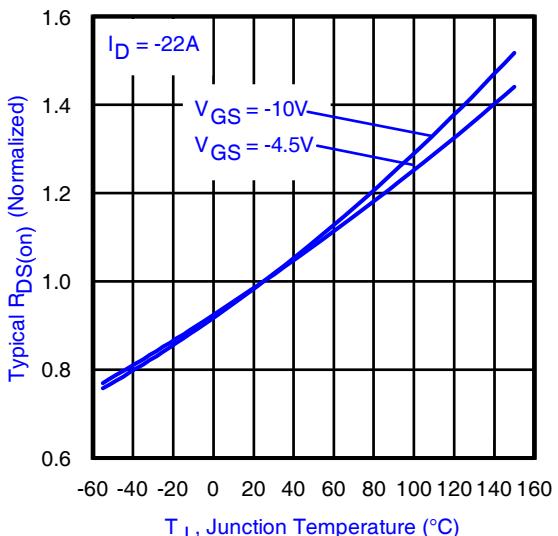


Fig 7. Normalized On-Resistance vs. Temperature

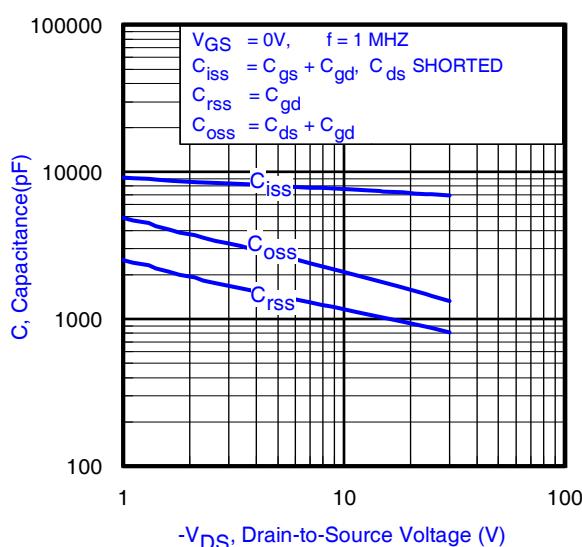


Fig 8. Typical Capacitance vs. Drain-to-Source Voltage

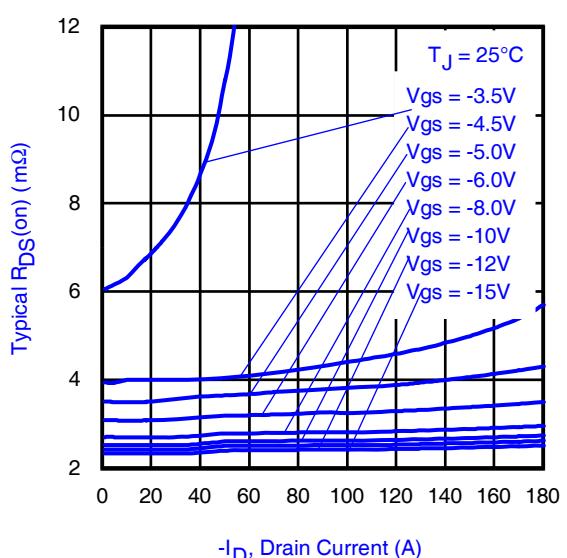


Fig 9. Typical On-Resistance vs. Drain Current and Gate Voltage

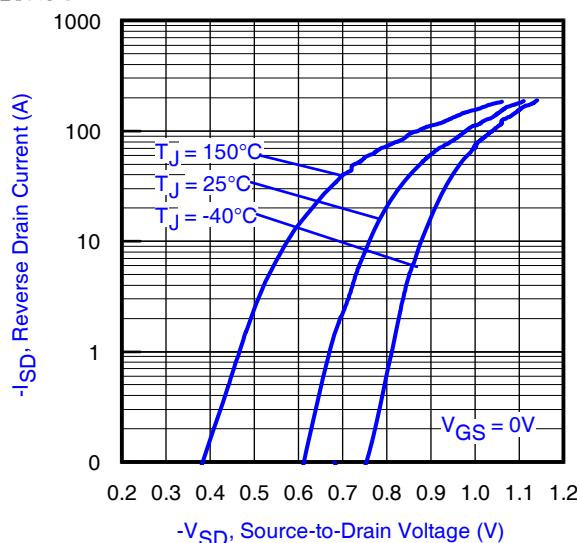


Fig 10. Typical Source-Drain Diode Forward Voltage

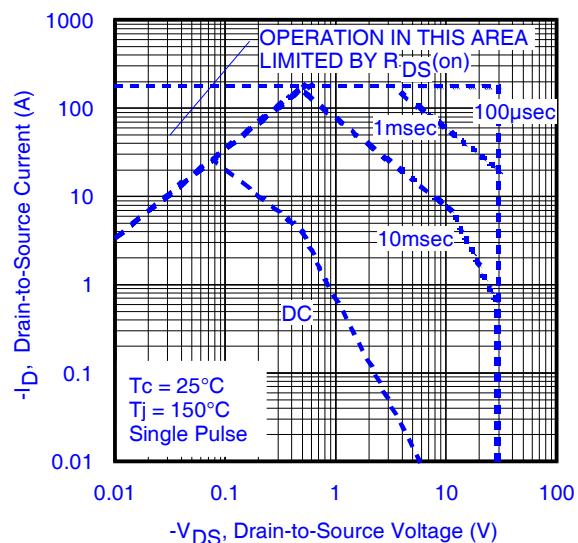


Fig 11. Maximum Safe Operating Area

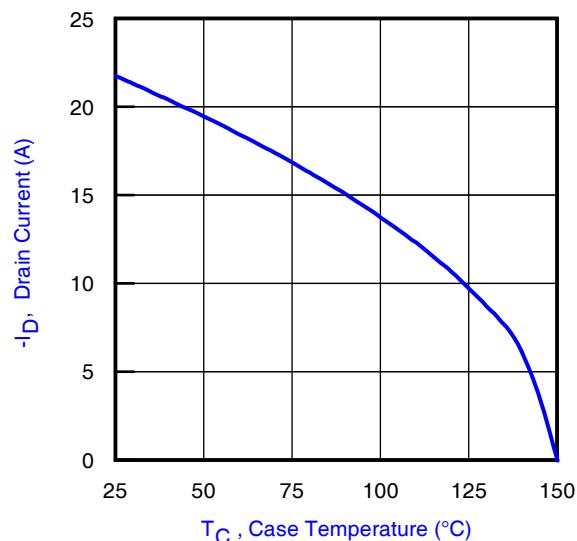


Fig 12. Maximum Drain Current vs. Case Temperature

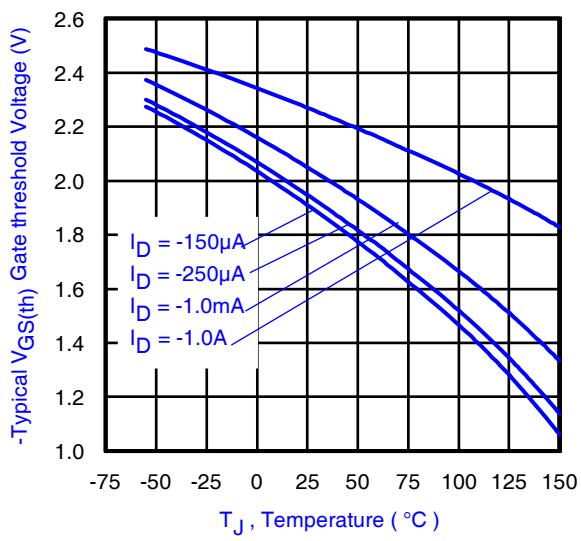


Fig 13. Typical Threshold Voltage vs. Junction Temperature

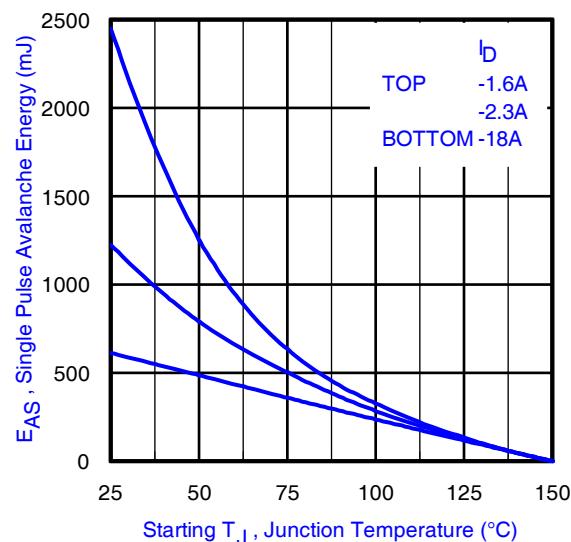


Fig 14. Maximum Avalanche Energy vs. Drain Current

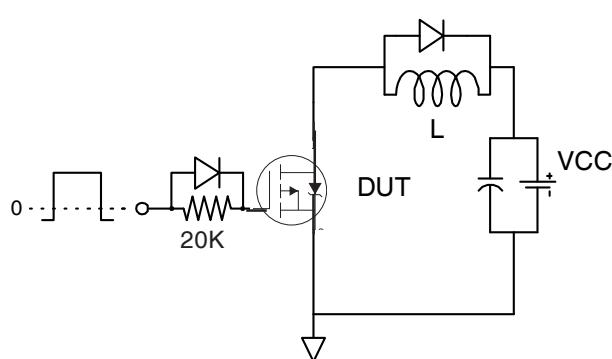


Fig 17a. Gate Charge Test Circuit

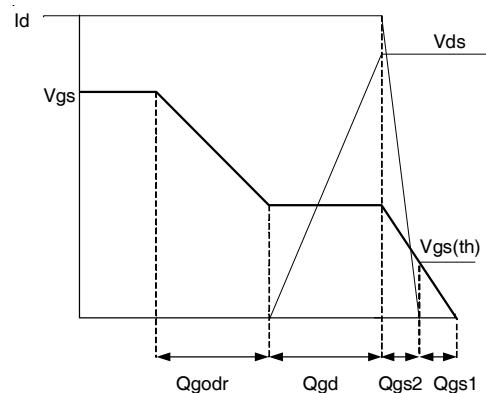


Fig 17b. Gate Charge Waveform

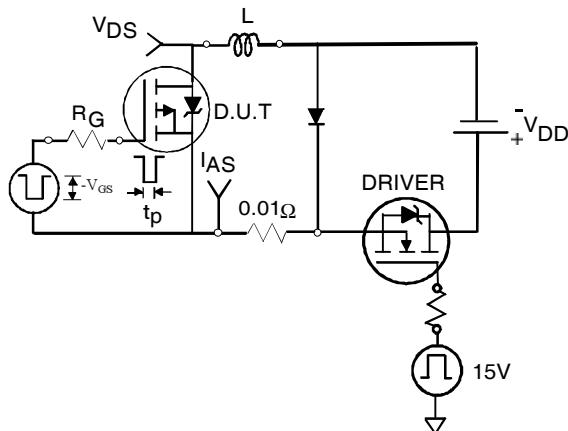


Fig 18a. Unclamped Inductive Test Circuit

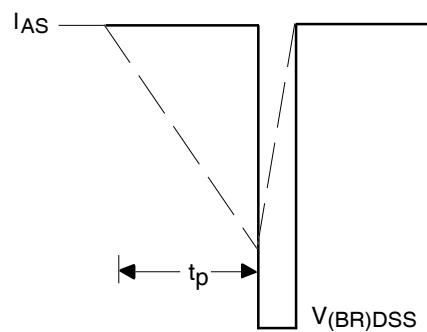


Fig 18b. Unclamped Inductive Waveforms

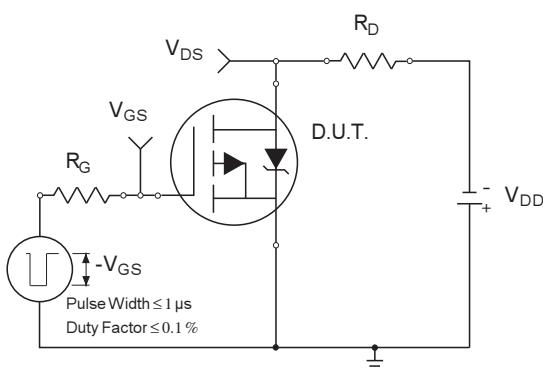


Fig 19a. Switching Time Test Circuit

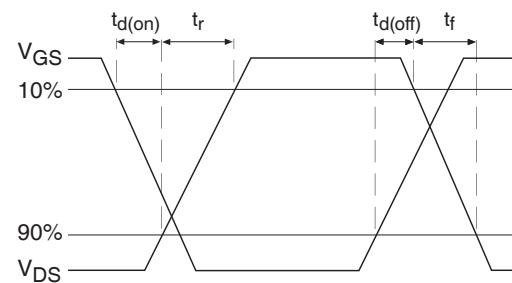


Fig 19b. Switching Time Waveforms

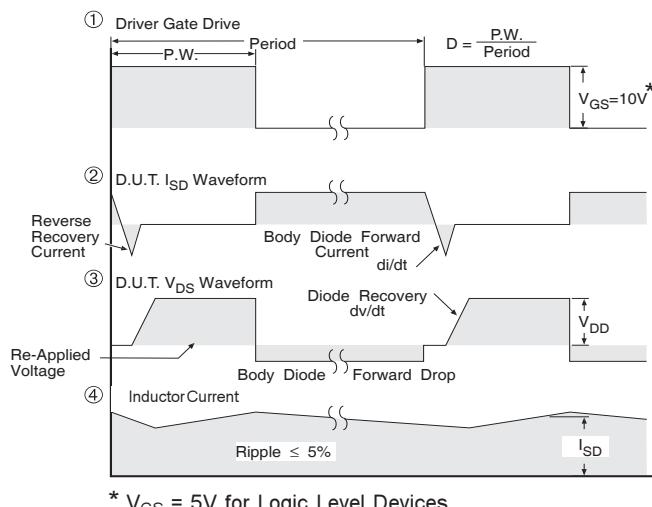
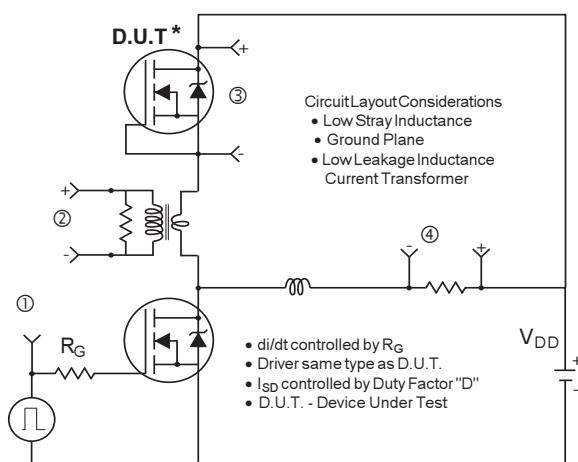
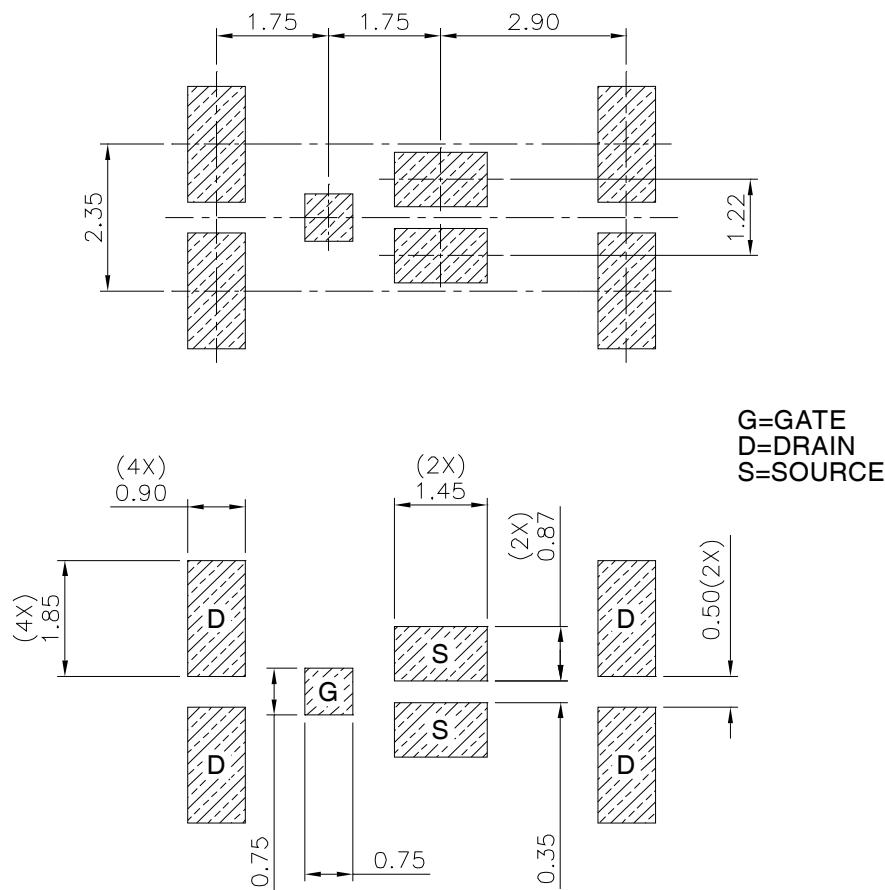


Fig 20. Diode Reverse Recovery Test Circuit for P-Channel HEXFET® Power MOSFETs

DirectFET® Board Footprint, MX Outline (Medium Size Can, X-Designation).

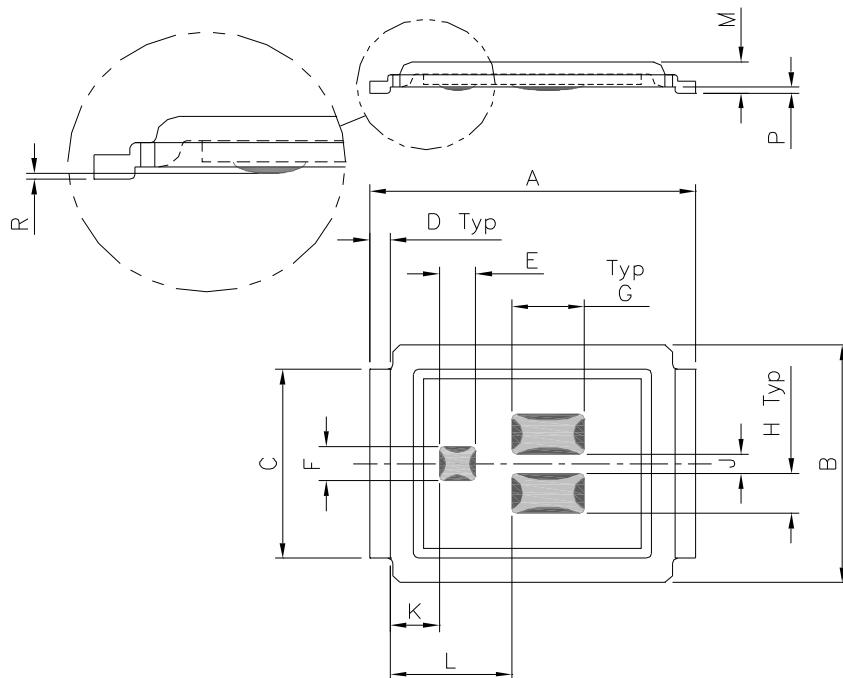
Please see DirectFET application note AN-1035 for all details regarding the assembly of DirectFET.

This includes all recommendations for stencil and substrate designs.



DirectFET® Outline Dimension, MX Outline (Medium Size Can, X-Designation).

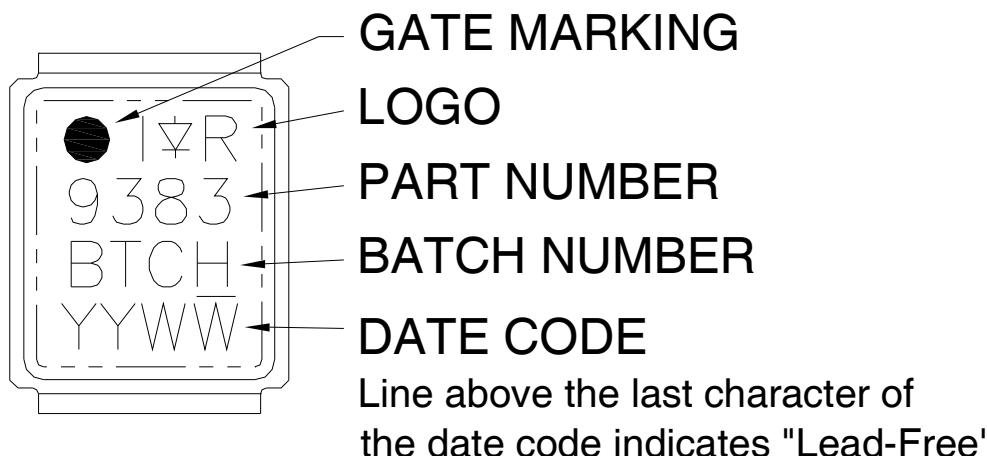
Please see DirectFET application note AN-1035 for all details regarding the assembly of DirectFET. This includes all recommendations for stencil and substrate designs.



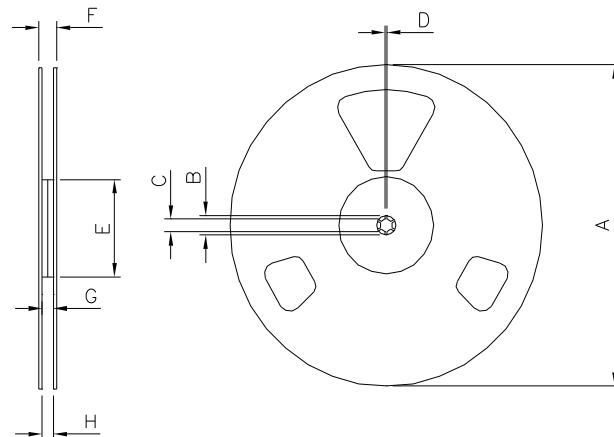
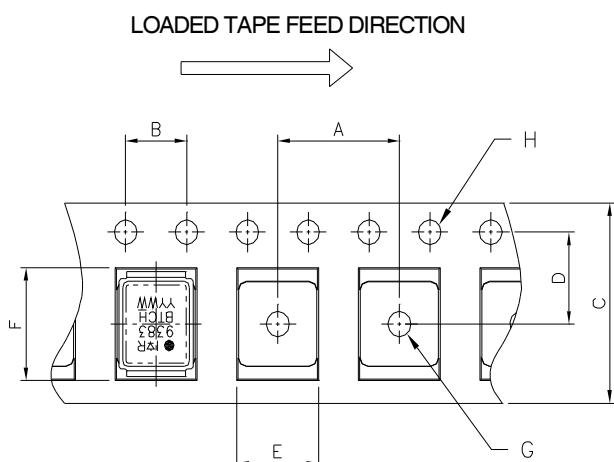
CODE	DIMENSIONS			
	METRIC	IMPERIAL	MIN	MAX
A	6.25	6.35	0.246	0.250
B	4.80	5.05	0.189	0.199
C	3.85	3.95	0.152	0.156
D	0.35	0.45	0.014	0.018
E	0.68	0.72	0.027	0.028
F	0.68	0.72	0.027	0.028
G	1.38	1.42	0.054	0.056
H	0.80	0.84	0.031	0.033
J	0.38	0.42	0.015	0.017
K	0.88	1.02	0.035	0.040
L	2.28	2.42	0.090	0.095
M	0.59	0.70	0.023	0.028
R	0.03	0.08	0.001	0.003
P	0.08	0.17	0.003	0.007

Dimensions are shown in
millimeters (inches)

DirectFET® Part Marking



DirectFET® Tape & Reel Dimension (Showing component orientation).



NOTE: Controlling dimensions in mm
Std reel quantity is 4800 parts. (ordered as IRF9383MTRPBF). For 1000 parts on 7" reel, order IRF9383MTR1PBF

NOTE: CONTROLLING DIMENSIONS IN MM

DIMENSIONS				
CODE	METRIC		IMPERIAL	
	MIN	MAX	MIN	MAX
A	7.90	8.10	0.311	0.319
B	3.90	4.10	0.154	0.161
C	11.90	12.30	0.469	0.484
D	5.45	5.55	0.215	0.219
E	5.10	5.30	0.201	0.209
F	6.50	6.70	0.256	0.264
G	1.50	N.C.	0.059	N.C.
H	1.50	1.60	0.059	0.063

REEL DIMENSIONS								
CODE	STANDARD OPTION (QTY 4800)				TR1 OPTION (QTY 1000)			
	METRIC	IMPERIAL	METRIC	IMPERIAL	METRIC	IMPERIAL	METRIC	IMPERIAL
A	330.0	N.C.	12.992	N.C.	177.77	N.C.	6.9	N.C.
B	20.2	N.C.	0.795	N.C.	19.06	N.C.	0.75	N.C.
C	12.8	13.2	0.504	0.520	13.5	12.8	0.53	0.50
D	1.5	N.C.	0.059	N.C.	1.5	N.C.	0.059	N.C.
E	100.0	N.C.	3.937	N.C.	58.72	N.C.	2.31	N.C.
F	N.C.	18.4	N.C.	0.724	N.C.	13.50	N.C.	0.53
G	12.4	14.4	0.488	0.567	11.9	12.01	0.47	N.C.
H	11.9	15.4	0.469	0.606	11.9	12.01	0.47	N.C.

Qualification Information[†]

Qualification level	Consumer ^{††}		
	(per JEDEC JESD47 ^{†††} guidelines)		
Moisture Sensitivity Level	DirectFET		MSL3
RoHS Compliant	(per JEDEC J-STD-020D ^{†††})		

[†] Qualification standards can be found at International Rectifier's web site

<http://www.irf.com/product-info/reliability>

^{††} Higher qualification ratings may be available should the user have such requirements.

Please contact your International Rectifier sales representative for further information:

<http://www.irf.com/photo-call/salesrep/>

^{†††} Applicable version of JEDEC standard at the time of product release.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Data and specifications subject to change without notice.

International
IR Rectifier

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